

HEXFET® Chip-Set for DC-DC Converters

- N Channel Application Specific MOSFETs
- Ideal for Mobile DC-DC Converters
- Low Conduction Losses
- Low Switching Losses
- Lead-Free



Description

This new device employs advanced HEXFET Power MOSFET technology to achieve an unprecedented balance of on-resistance and gate charge. The reduced conduction and switching losses make this device ideal for high efficiency DC-DC Converters that power the latest generation of mobile microprocessors.

The IRF7805PbF offers maximum efficiency for mobile CPU core DC-DC converters.

Devices Features

| | IRF7805PbF |
|---------------------|------------|
| V _{DSS} | 30V |
| R _{DS(on)} | 11mΩ |
| Qg | 31nC |
| Q _{sw} | 11.5nC |
| Qoss | 36nC |

| G | D | S |
|------|-------|--------|
| Gate | Drain | Source |

| Dage most sussibas | Dookses Ture | Standard Pack | Oudership Deat Newsher | |
|--------------------|--------------|---------------|------------------------|-----------------------|
| Base part number | Package Type | Form | Quantity | Orderable Part Number |
| IRF7805PbF | SO-8 | Tape and Reel | 4000 | IRF7805PbF |

| Symbol | Parameter | Max. | Units |
|--|---|--------------|-------|
| V_{DS} | Drain-Source Voltage | 30 | ., |
| V_{GS} | Gate-to-Source Voltage | ± 12 | V |
| I _D @ T _A = 25°C | Continuous Drain Current, V _{GS} @ 10V ③ | 13 | |
| I _D @ T _A = 70°C | Continuous Drain Current, V _{GS} @ 10V 3 | 10 | Α |
| I _{DM} | Pulsed Drain Current ① | 100 | |
| P _D @T _A = 25°C | Maximum Power Dissipation ③ | 2.5 | 10/ |
| P _D @T _A = 70°C | Maximum Power Dissipation ③ | 1.6 | W |
| | Linear Derating Factor | 0.02 | W/°C |
| T_J | Operating Junction and | -55 to + 150 | °C |
| T_{STG} | Storage Temperature Range | | C |

Thermal Resistance

| Symbol | Parameter | Тур. | Max. | Units |
|----------------|-------------------------|------|------|-------|
| $R_{	heta JL}$ | Junction-to-Drain Lead® | | 20 | °CAM |
| $R_{	heta JA}$ | Junction-to-Ambient ③ | | 50 | °C/W |

2016-8-23



Static @ T_J = 25°C (unless otherwise specified)

| | Parameter | Min. | Тур. | Max. | Units | Conditions |
|---------------------|--|------|------|------|-------|---|
| $V_{(BR)DSS}$ | Drain-to-Source Breakdown Voltage ® | 30 | | | V | $V_{GS} = 0V, I_D = 250\mu A$ |
| R _{DS(on)} | Static Drain-to-Source On-Resistance © | | 9.2 | 11 | mΩ | V _{GS} = 4.5V, I _D = 7.0A ② |
| $V_{GS(th)}$ | Gate Threshold Voltage © | 1.0 | | 3.0 | V | $V_{DS} = V_{GS}$, $I_D = 250\mu A$ |
| | | | | 70 | | $V_{DS} = 30V, V_{GS} = 0V$ |
| I _{DSS} | Drain-to-Source Leakage Current | | | 10 | | $V_{DS} = 24V, V_{GS} = 0V$ |
| | | | | 150 | | $V_{DS} = 24V, V_{GS} = 0V, T_{J} = 100^{\circ}C$ |
| | Gate-to-Source Forward Leakage | | | 100 | nA | V _{GS} = 12V |
| I _{GSS} | Gate-to-Source Reverse Leakage | | | -100 | ПА | $V_{GS} = -12V$ |

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

| Q_g | Total Gate Charge © | | 22 | 31 | | |
|----------------|--------------------------------|-----|-----|------|----|--|
| Q_{gs1} | Pre -Vth Gate-to-Source Charge | | 3.7 | | | V _{GS} = 5.0V |
| Q_{gs2} | Post-Vth Gate-to-Source Charge | | 1.4 | | nC | V _{DS} = 16V |
| Q_{gd} | Gate-to-Drain Charge | | 6.8 | | | $I_{D} = 7.0A$ |
| Q_{sw} | Switch Charge (Qgs2 + Qgd) ® | | 8.2 | 11.5 | | |
| Q_{oss} | Output Charge © | | 30 | 36 | nC | $V_{DS} = 16V, V_{GS} = 0V$ |
| R_G | Gate Resistance | 0.5 | | 1.7 | Ω | |
| $t_{d(on)}$ | Turn-On Delay Time | | 16 | | | V _{DD} = 16V,V _{GS} = 4.5V ② |
| t _r | Rise Time | _ | 20 | | no | $I_{D} = 7.0A$ |
| $t_{d(off)}$ | Turn-Off Delay Time | | 38 | | ns | $R_G = 2\Omega$ |
| t _f | Fall Time | | 16 | | | Resistive Load |

Diode Characteristics

| | Parameter | Min. | Тур. | Max. | Units | Conditions |
|-----------------|--|------|------|------|-------|---|
| Is | Continuous Source Current (Body Diode) ① | | | 2.5 | | MOSFET symbol showing the |
| I _{SM} | Pulsed Source Current (Body Diode) | | | 106 | | integral reverse p-n junction diode. |
| V_{SD} | Diode Forward Voltage® | | | 1.2 | V | $T_J = 25^{\circ}C, I_S = 7.0A, V_{GS} = 0V$ |
| Q _{rr} | Reverse Recovery Charge ④ | | 88 | | | di/dt = $700A/\mu s$ V _{DS} = $16V$, V _{GS} = $0V$, I _S = $7.0A$ |
| Q _{rr} | Reverse Recovery Charge ④ | | 55 | | | di/dt = 700A/ μ s (with 10BQ040) V _{DS} =16V, V _{GS} = 0V, I _S = 7.0A |

Notes:

- $\, \oplus \,$ Repetitive rating; pulse width limited by max. junction temperature.
- ② Pulse width $\leq 300 \mu s$; duty cycle $\leq 2\%$.
- ③ When mounted on 1" in square copper board, t < 10 sec.
- 4 Typ = measured Q_{OSS}
- ⑤ R_{θ} is measured at T_{J} of approximately 90°C.
- © Devices are 100% tested to these parameters.

2016-8-23



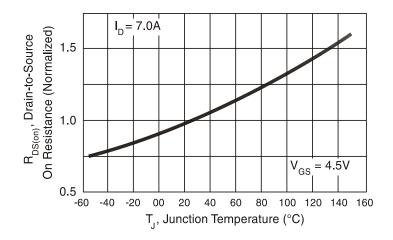


Fig. 1 Normalized On-Resistance vs. Temperature

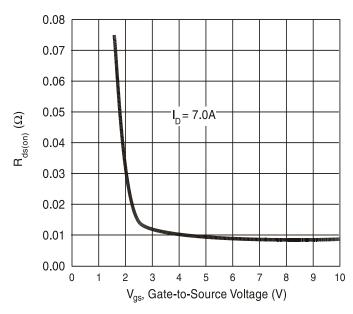


Fig. 3 Typical Rds(on) vs. Gate-to-Source Voltage

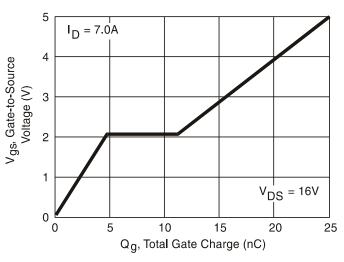


Fig. 2 Typical Gate Charge vs. Gate-to-Source Voltage

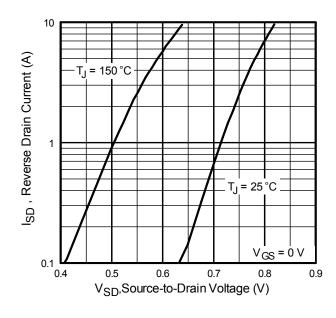


Fig. 4 Typical Source-Drain Diode Forward Voltage

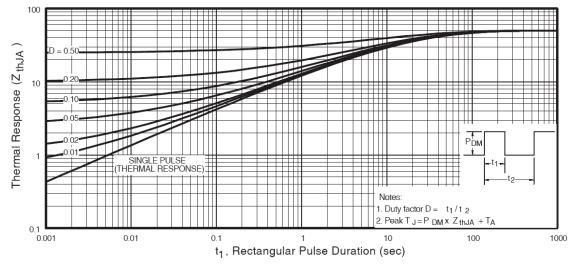
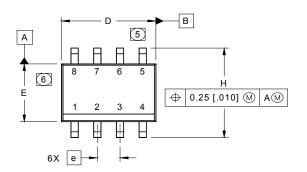


Fig 5. Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

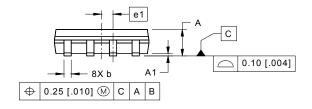
3 2016-8-23

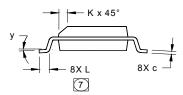


SO-8 Package Outline (Dimensions are shown in millimeters (inches)

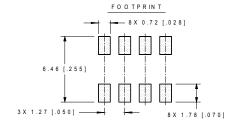


| DIM | INC | HES | MILLIM | ETERS |
|-------|------------|------------|------------|-------|
| DIIVI | MIN | MAX | MIN | MAX |
| Α | .0532 | .0688 | 1.35 | 1.75 |
| A1 | .0040 | .0098 | 0.10 | 0.25 |
| b | .013 | .020 | 0.33 | 0.51 |
| С | .0075 | .0098 | 0.19 | 0.25 |
| D | .189 | .1968 | 4.80 | 5.00 |
| Е | .1497 | .1574 | 3.80 | 4.00 |
| е | .050 BASIC | | 1.27 BASIC | |
| e 1 | .025 B | .025 BASIC | | BASIC |
| Н | .2284 | .2440 | 5.80 | 6.20 |
| K | .0099 | .0196 | 0.25 | 0.50 |
| L | .016 | .050 | 0.40 | 1.27 |
| у | 0° | 8° | 0° | 8° |



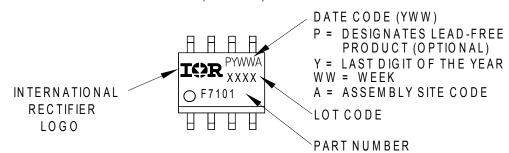


- 1. DIMENSIONING & TOLERANCING PER ASME Y14.5M -1994
- CONTROLLING DIMENSION: MILLIMETER
- DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES]. OUTLINE CONFORMS TO JEDEC OUTLINE MS-012AA
- [5] DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS MOLD PROTRUSIONS NOT TO EXCEED 0.15 [.006].
- 6 DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS MOLD PROTRUSIONS NOT TO EXCEED 0.25 [.010].
- 7 DIMENSION IS THE LENGTH OF LEAD FOR SOLDERING TO A SUBSTRATE.



SO-8 Part Marking Information

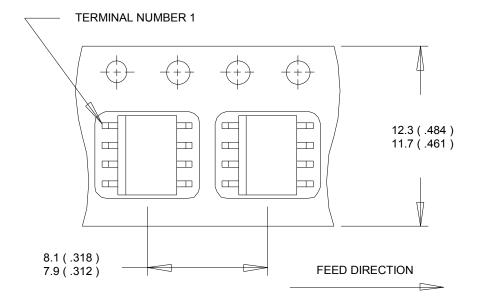
EXAMPLE: THIS IS AN IRF7101 (MOSFET)



2016-8-23

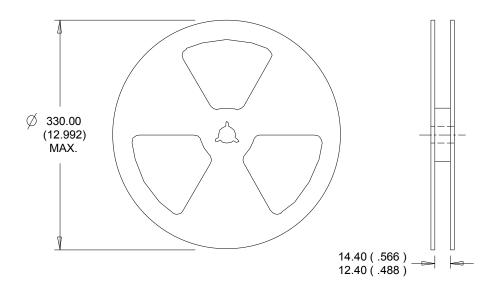


SO-8 Tape and Reel (Dimensions are shown in millimeters (inches)



NOTES:

- 1. CONTROLLING DIMENSION: MILLIMETER.
- 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS(INCHES).
- 3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



NOTES:

- 1. CONTROLLING DIMENSION: MILLIMETER.
- 2. OUTLINE CONFORMS TO EIA-481 & EIA-541.

5 2016-8-23



Qualification Information

| Qualification Level | Consumer | | | | |
|----------------------------|---|--|--|--|--|
| Moisture Sensitivity Level | SO-8 MSL1 (per JEDEC J-STD-020D) [†] | | | | |
| RoHS Compliant | Yes | | | | |

[†] Applicable version of JEDEC standard at the time of product release.

Revision History

| Date | Comments | | | |
|------------|---|--|--|--|
| 08/23/2016 | Changed datasheet with Infineon logo - all pages. Corrected typo Qoss from typ/max "3.0nC/3.6nC" to "30nC/36nC" on page 2. Added disclaimer on last page. | | | |

Trademarks of Infineon Technologies AG

µHVIC™, µIPM™, µPFC™, AU-ConvertIR™, AURIX™, C166™, CanPAK™, CIPOS™, CIPURSE™, CoolDP™, CoolGaN™, COOLIR™, CoolMOS™, CoolSET™, CoolSet™, DAVE™, DI-POL™, DirectFET™, DrBlade™, EasyPIM™, EconoBRIDGE™, EconoDUAL™, EconoPACK™, EconoPIM™, EiceDRIVER™, eupec™, FCOS™, GaNpowIR™, HEXFET™, HITFET™, HybridPACK™, iMOTION™, IRAM™, ISOFACE™, IsoPACK™, LEDrivIR™, LITIX™, MIPAQ™, ModSTACK™, my-d™, NovalithIC™, OPTIGA™, OptiMOS™, ORIGA™, PowIRaudio™, PowIRStage™, PrimePACK™, PrimeSTACK™, PROFET™, PRO-SIL™, RASIC™, REAL3™, SmartLEWIS™, SOLID FLASH™, SPOC™, StrongIRFET™, SupIRBuck™, TEMPFET™, TRENCHSTOP™, TriCore™, UHVIC™, XHP™, XMC™

Trademarks updated November 2015

Other Trademarks

All referenced product or service names and trademarks are the property of their respective owners.

Edition 2016-04-19 Published by Infineon Technologies AG 81726 Munich, Germany

© 2016 Infineon Technologies AG. All Rights Reserved.

Do you have a question about this document?

Email: erratum@infineon.com

Document reference ifx1

IMPORTANT NOTICE

The information given in this document shall in no event be regarded as a guarantee of conditions or **characteristics ("Beschaffenheitsgarantie").**

With respect to any examples, hints or any typical values stated herein and/or any information regarding the application of the product, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation warranties of non-infringement of intellectual property rights of any third party.

In addition, any information given in this document is subject to customer's compliance with its obligations stated in this document and any applicable legal requirements, norms and standards concerning customer's products and any use of the product of Infineon Technologies in customer's applications.

The data contained in this document is exclusively intended for technically trained staff. It is the responsibility of customer's technical departments to evaluate the suitability of the product for the intended application and the completeness of the product information given in this document with respect to such application.

For further information on the product, technology, delivery terms and conditions and prices please contact your nearest Infineon Technologies office (www.infineon.com).

Please note that this product is not qualified according to the AEC Q100 or AEC Q101 documents of the Automotive Electronics Council.

WARNINGS

Due to technical requirements products may contain dangerous substances. For information on the types in question please contact your nearest Infineon Technologies office.

Except as otherwise explicitly approved by Infineon Technologies in a written document signed by authorized representatives of Infineon Technologies, Infineon Technologies' products may not be used in any applications where a failure of the product or any consequences of the use thereof can reasonably be expected to result in personal injury.

6 2016-8-23